

IN THE CLAIMS

Please amend the claims as follows:

1. (Amended) A method for forming a field emitter device on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter device;
forming a polysilicon cone on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the polysilicon cone are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the polysilicon cone from the gate; and
forming an anode opposing the polysilicon cone.
2. (Original) The method of claim 1, wherein forming the field emitter device on a substrate includes forming the device on a silicon dioxide (SiO₂) substrate.
3. (Amended) The method of claim 1, wherein ~~forming the polysilicon cone and the porous oxide layer from a single layer of polysilicon includes masking a cathode region on the substrate~~ a first component of the multiple component mask is used to form the polysilicon cone and the porous oxide layer, and wherein a second component of the multiple component mask is used to form the gate layer.
4. (Amended) The method of claim 3 1, wherein ~~masking the cathode region~~ forming and utilizing a multiple component mask includes:
forming an oxide-nitride-oxide (ONO) mask over the cathode region;
forming the porous oxide layer;
removing the top oxide from the ONO mask;
etching the nitride to reduce the width of the mask; and
forming the gate layer on the porous oxide and the mask.

5. (Amended) The method of claim 3 1, wherein ~~masking the cathode region~~ forming and utilizing a multiple component mask includes:

- forming an oxide layer over the cathode region;
- forming a first nitride layer over the oxide layer in order to form a structure which reflects the final pattern of the gate layer;
- forming a second nitride layer over the first nitride layer and the single polysilicon layer;
- etching the second nitride layer, leaving the second nitride layer only on the sidewalls of the structure; and
- forming the porous oxide layer;
- removing the first and second nitride layers; and
- forming the gate layer on the porous oxide and the oxide layer.

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Concluded

6. (Original) The method of claim 5, wherein forming the porous oxide layer includes:

- performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and
- oxidizing the porous polysilicon.

7. (Original) The method of claim 1, wherein forming a polysilicon cone includes forming a metal silicide on the polysilicon cone.

8. (Original) The method of claim 7, wherein forming a metal silicide on the polysilicon cone includes using a electron beam to deposit molybdenum (Mo) on the polysilicon cone.

9. (Original) The method of claim 1, wherein forming a gate on the porous oxide layer includes forming a refractory metal gate.

10. (Original) The method of claim 1, wherein isolating the polysilicon cone from the gate includes:

- shaping the gate material in close proximity to a top surface of the polysilicon cone using a lift-off technique; and

removing the porous oxide layer adjacent to the polysilicon cone.

11. (Original) The method of claim 1, wherein forming the porous oxide layer includes: performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and oxidizing the porous polysilicon.

12. (Amended) A field emitter device on a substrate, comprising:
a cathode formed in a cathode region of the substrate;
a gate insulator formed in an insulator region of the substrate;
a gate formed on the gate insulator; and
an anode opposing the cathode, the field emitter device formed by a method comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter device;
forming a polysilicon cone on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the polysilicon cone are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the polysilicon cone from the gate; and
forming an anode opposing the cathode.

13. (Amended) The field emitter device of claim 12, wherein ~~forming the polysilicon cone and the porous oxide layer from a single layer of polysilicon~~ includes masking a cathode region on the substrate a first component of the multiple component mask is used to form the polysilicon cone and the porous oxide layer, and wherein a second component of the multiple component mask is used to form the gate layer.

14. (Amended) The field emitter device of claim ~~13~~ 12, wherein ~~masking the cathode region~~ forming and utilizing a multiple component mask includes:
forming a oxide-nitride-oxide (ONO) mask over the cathode region;

forming the porous oxide layer;
removing the top oxide from the ONO mask;
etching the nitride to reduce the width of the mask; and
forming the gate layer on the porous oxide and the mask.

15. (Amended) The field emitter device of claim 12, wherein ~~masking the cathode region~~
forming and utilizing a multiple component mask includes:

forming an oxide layer over the cathode region;
forming a first nitride layer over the oxide layer in order to form a structure which
reflects the final pattern of the gate layer;
forming a second nitride layer over the first nitride layer and the single polysilicon layer;
etching the second nitride layer, leaving the second nitride layer only on the sidewalls of
the structure; and
forming the porous oxide layer;
removing the first and second nitride layers; and
forming the gate layer on the porous oxide and the oxide layer.

16. (Amended) A method for forming a field emitter device on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the
multiple component mask are used to form selected elements of the field emitter device;

forming a cathode on the substrate;
forming a gate insulator layer on the substrate, wherein the gate insulator layer and the
cathode are formed from a single layer of polysilicon;
forming a gate layer on the gate insulator layer;
isolating the cathode from the gate; and
forming an anode opposing the cathode.

17. (Original) The method of claim 16, wherein forming the field emitter device on a
substrate includes forming the device on a silicon dioxide (SiO₂) substrate.

18. (Original) The method of claim 16, wherein forming a polysilicon cone includes forming a metal silicide on the polysilicon cone.

19. (Amended) The method of claim 16, wherein forming a gate the gate layer on the porous oxide gate insulator layer includes forming a refractory metal gate layer.

20. (Amended) A method of forming a field emitter array on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;

forming a number of cathodes on the substrate;

forming a gate insulator layer on the substrate, wherein the gate insulator layer and the number of cathodes are formed from a single layer of polysilicon;

forming a gate layer on the gate insulator layer;

isolating the number of cathodes from the gate; and

forming a number of anodes opposing the number of cathodes.

21. (Original) The method of claim 20, wherein forming the field emitter array on a substrate includes forming the array on a silicon dioxide (SiO₂) substrate.

22. (Original) The method of claim 20, wherein forming the gate insulator layer includes forming a porous oxide layer.

23.. (Amended) A method of forming a flat panel display, comprising:

forming a field emitter array on a substrate, including:

forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;

forming a number of cathodes on the substrate;

forming a gate insulator layer on the substrate, wherein the gate insulator layer and the number of cathodes are formed from a single layer of polysilicon;

forming a gate layer on the gate insulator layer;

isolating the number of cathodes from the gate;
forming a number of anodes opposing the number of cathodes;
coupling a row decoder and a column decoder to the field emitter array; and
coupling a processor to the row and column decoders.

24. (Original) The method of claim 23, wherein forming the field emitter array on a substrate includes forming the array on a silicon dioxide (SiO₂) substrate.

25. (Original) The method of claim 23, wherein forming a number of cathodes on the substrate includes forming a number of polysilicon cones on the substrate.

26. (Amended) A method for forming a field emitter array on a substrate, comprising:
forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;
forming a number of polysilicon cones on the substrate;
forming a porous oxide layer on the substrate, wherein the porous oxide layer and the number of polysilicon cones are formed from a single layer of polysilicon;
forming a gate layer on the porous oxide layer;
isolating the number of polysilicon cones from the gate; and
forming a number of anodes opposing the number of polysilicon cones.

27. (Original) The method of claim 26, wherein forming the porous oxide layer includes:
performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and
oxidizing the porous polysilicon.

28. (Amended) The method of claim 26, wherein forming a ~~polysilicon cone~~ number of polysilicon cones includes forming a metal silicide on the ~~polysilicon cone~~ number of polysilicon cones.

29. (Amended) A method of forming a flat panel display, comprising:

forming a field emitter array on a substrate, including:

forming and utilizing a multiple component mask, wherein separate components of the multiple component mask are used to form selected elements of the field emitter array;

forming a number of polysilicon cones on the substrate;

forming a porous oxide layer on the substrate, wherein the porous oxide layer and the number of polysilicon cones are formed from a single layer of polysilicon;

forming a gate layer on the porous oxide layer;

isolating the number of polysilicon cones from the gate;

forming a number of anodes opposing the number of polysilicon cones;

coupling a row decoder and a column decoder to the field emitter array; and

coupling a processor to the row and column decoders.

30. (Original) The method of claim 29, wherein forming the porous oxide layer includes:

performing an anodic etch on the single polysilicon layer in an insulator region of the substrate to form porous polysilicon; and

oxidizing the porous polysilicon.

31. (Original) The method of claim 29, wherein forming a gate on the porous oxide layer includes forming a refractory metal gate.
